

<b>Notice of References Cited</b>	Application/Control No. 10/783,645		Applicant(s)/Patent Under Reexamination PLEASANT, DANIEL L.	
	Examiner Andre Pierre-Louis		Art Unit 2123	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,804,807	10-2004	Jamneala et al.	716/4
*	B	US-2005/0174562	08-2005	Cedilnik, Gregor	356/073.1
*	C	US-6,118,844	09-2000	Fischer, Helmut	378/48
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Piratelli-Filho et al. (Uncertainty Evaluation in small angle Calibration using ISO GUM Approach and Monte Carlo Method, June 2003).
	V	Argilent ADS (Harmonic Balance Simulation on ADS, 01/2003). □□
	W	Helisto et al. (Measurement Uncertainty in the 1/f noise region: Zener Voltage Standards, IEEE 2000).
	X	Anritsu (Application Note: Three and Four Port S-parameter Measurements, 04/2002).

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.